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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Appln. Of: ONISHI, et al.  
Serial No. 10/598,446  
Filed: August 30, 2006  
For: PIEZOELECTRIC ACOUSTIC ELEMENT, ACOUSTIC DEVICE,...  
DOCKET: NEC 04P302

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

**INFORMATION DISCLOSURE STATEMENT**

Dear Sir:

In connection with the above-identified application, Applicants hereby attach U.S. Patent Office form PTO-1449, including copies of the prior art references listed therein. These references were cited in the specification<sup>1</sup> and/or the International Search Report dated March 22, 2005 of the corresponding PCT patent application. Enclosed also is a copy of the International Search Report. The claims in the present application are believed to be patentably distinguished over these references.

This information disclosure statement is being made pursuant to the duty of disclosure imposed by law and formulated in 37 CFR §1.56(A). No representation is made that the information thus disclosed in fact constitutes prior art or that it is the closest prior art, inasmuch as 37 CFR §1.56(A) relies on a materiality concept which depends on subjectivity.

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<sup>1</sup> Two of the listings in the Specification were typed incorrectly, and are being corrected by Preliminary Amendment.

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In compliance with the requirements of 37 CFR §1.98(a)(3), as a concise statement of relevance, as it is presently understood by the individual designated in 35 U.S.C. §1.56(c) most knowledgeable about the content of the information, the undersigned attorney of record submits a copy of the Search Report by a foreign examiner in which the references were cited. The relevance to the pending U.S. patent application is that the references were cited in a foreign patent application on the same subject matter. However, no independent analysis of the references, the accuracy of the statement of the foreign examiner or the claims of the foreign application under the laws of the country or the United States relative to the subject matter claimed in the present application has been made; the present understanding of the contents thereof by the undersigned being based on the translation of the foreign examiner's comments submitted herewith.

We believe that there are no fees involved with this Information Disclosure Statement. However, in the event there are any fees payable, please charge them to our Deposit Account No. 08-1391.

Respectfully submitted,



Norman P. Soloway  
Attorney for Applicants  
Reg. No. 24, 315

**CERTIFICATE OF MAILING**


I hereby certify that this correspondence is being deposited with the United States Postal Service as First Class Mail in an envelope addressed to: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450 on August 30, 2006, at Tucson, Arizona.

By 

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|  <p><b>INFORMATION DISCLOSURE CITATION</b><br/>(Use several sheets if necessary)</p> | ATTY DOCKET NO.<br><b>NEC 04P302</b>  | APPLICATION NO.<br><b>10/598,446</b> |
|   | APPLICANT(S)<br><b>ONISHI, et al.</b> |                                      |
|   | FILING DATE<br><b>August 30, 2006</b> | GROUP ART UNIT                       |

**U.S. PATENT DOCUMENTS**

| *EXAMINER<br>INITIAL | DOCUMENT NUMBER | DATE | NAME | CLASS | SUBCLASS | FILING DATE<br>IF APPROPRIATE |
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**FOREIGN PATENT DOCUMENTS**

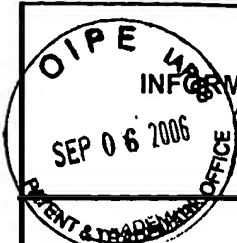
|  |  | DOCUMENT NUMBER | DATE       | COUNTRY            | CLASS | SUBCLASS | TRANSLATION |    |
|--|--|-----------------|------------|--------------------|-------|----------|-------------|----|
|  |  |                 |            |                    |       |          | YES         | NO |
|  |  | 04-022300       | 27.01.1992 | JAPAN (w/Abstract) | H04R  | 17/00    |             | ✓  |
|  |  | 63-81495        | 28.05.1988 | JAPAN              | H04R  | 17/00    |             | ✓  |
|  |  | 58-008000       | 17.01.1983 | JAPAN (w/Abstract) | H04R  | 17/00    |             | ✓  |
|  |  | 09-298798       | 18.11.1997 | JAPAN (w/Abstract) | H04R  | 17/00    |             | ✓  |
|  |  | 10-094093       | 10.04.1998 | JAPAN (w/Abstract) | H04R  | 17/00    |             | ✓  |

**OTHER DOCUMENTS** (Including Author, Title, Date, Pertinent Pages, Etc.)

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\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

**INFORMATION DISCLOSURE CITATION***(Use several sheets if necessary)*ATTY DOCKET NO.  
**NEC 04P302**APPLICATION NO.  
**10/598,446****ONISHI, et al.**FILING  
**August 30, 2006**

GROUP ART

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|  |  | DOCUMENT NUMBER | DATE       | COUNTRY            | CLASS | SUBCLASS | TRANSLATION |    |
|--|--|-----------------|------------|--------------------|-------|----------|-------------|----|
|  |  |                 |            |                    |       |          | YES         | NO |
|  |  | 2004-274593     | 30.09.2004 | JAPAN (w/Abstract) | H04R  | 1/00     |             | ✓  |
|  |  | 2002-102799     | 09.04.2002 | JAPAN (w/Abstract) | B06B  | 1/12     |             | ✓  |
|  |  |                 |            |                    |       |          |             |    |
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